Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/667,382	ISHII, AKIRA	
Examiner	Art Unit	
Quang N. Vo	2625	

SEARCHED					
Class	Subclass	Date	Examiner		
358	3.06	5/2/2007	QV .		
358	1.9	5/2/2007	QV		
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INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
US Pat, US PG Pub, USOCR, EPO, JPO, DERWENT, IBM	5/2/2007	QV		
Inventor Name Search, see attachment	5/2/2007	QV		
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